

U.S. PATENT DOCUMENTS						
EXAMINER INITIALS	DOCUMENT NUMBER	ISSUE DATE	PATENTEE	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

	FOREIGN PATENT DOCUMENTS							
EXAMINER	DOCUMENT	PUBLICATION	COUNTRY OR			TRANS	LATION	
INITIALS	NUMBER	DATE	PATENT OFFICE	CLASS	SUBCLASS	YES	NO	
129	WO 97/18461	05/1997	WIPO (English translation of claims only)					

	OTHER DOCUMENTS
EXAMINER INITIALS	Include name of the author (in CAPITAL LETTERS), title of the article, title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.
pp	English translation of previously filed German Article, Technologieland Nordrhein-Westfalen, "Tagungsunterlagen," Entire Document, 5. und 6. September 1996, Aachen, Karman-Auditorium; entitled "Current Developments and Industrial Use of Image Processing; Measuring Image Processing in Automation Technology"
	English translation of previously German Article "Industrielle Bildverarbeitung/Machine Vision, Markte Trends Bezugsquellen, Faehgemeinschaft Robotik + Automation (no date) 2 pages; entitled "Industrial Image Processing/Machine Vision"
180	English translation of previously filed German Article, Technologieland Nordrhein-Westfalen, "Tagungsband" Entire Document, 11.und 12. September 1997, Aachen, Karman-Auditorium; entitled: "Current Developments and Implementation of Image Processing; Overview of industrial applications of clear text and bar code identification"
720	English translation of previously filed German Article, "Einsatz der Bildverarbeitung zur Druckvollstandigkeitskontrolle," Entire Document, 11. und 12.September 1997, Aachen; entitled "Use of image processing for checking printing completeness"

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EXAMINER Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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FORM PTO-1449	Attorney Docket Number	40954/DBP/E43
	Application Number	Orga feralisa 5172
INFORMATION DISCLOSURE	Filing Date	November 15, 2000
STATEMENT BY APPLICANT	Applicant(s)	Munzke, et al.
	Group Art Unit	Not yet assigned
(use as many sheets as necessary)	Examiner Name	Not yet assigned

U.S. PATENT DOCUMENTS							
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100	5,486,692	01/1996	Baldwin	250	223 B		

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EXAMINER INITIALS	DOCUMENT NUMBER	PUBLICATION DATE	COUNTRY OR PATENT OFFICE	CLASS	SUBCLASS	YES	NO
200	WO 97/18461	05/1997	WIPO		!		
M	WO 98/04882	05/1998	WIPO				

EXAMINER INITIALS	Include name of the author (in CAPITAL LETTERS), title of the article, title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.
	O'GORMAN, "Subpixel Precision of Straight-Edged Shapes for Registration and Measurement", IEEE Transactions on Pattern Analysis and Machine Intelligence, July 1996, pgs. 746-751, Vol. 18, No 7
	STANKE ET AL., "High-Precision and Versatile Optical Measurement of Different Sides of IC's in the Confectioning Process using only one Viewpoint", Proceedings of the 24th Annual Conference of the IEEE Industrial Electronics Society, AACHEN, Germany, August 31, 1998 September 4, 1998, pgs. 2425-2427

EXAMINER SIGNATURE	DATE CONSIDERED	6/30/03
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FORM PTO-1449	Attorney Docket Number	40954/MEG/E43
	Application Number	09/700,572
INFORMATION DISCLOSURE	Filing Date	November 15, 2000
STATEMENT BY APPLICANT	Applicant(s)	Karl Heinz Munzke, et al.
	Group Art Unit	Not Yet Assigned
(use as many sheets as necessary)	Examiner Name	Not Yet Assigned

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OTHER DOCUMENTS						
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.00	German Article, Technologieland Nordrhein-Westfalen, "Tagungsunterlagen," Entire Document, 5. und 6. September 1996, Aachen, Karman-Auditorium					
	German Article "Industrielle Bildverarbeitung/Machine Vision, Markte Trends Bezugsquellen, Fachgemeinschaft Robotik + Automation (no date) 2 pages					
190	German Article, Technologieland Nordrhein-Westfalen, "Tagungsband" Entire Document, 11.und 12. September 1997, Aachen, Karman-Auditorium					
R	German Article, "Einsatz der Bildverarbeitung zur Druckvollstandigkeitskontrolle," Entire Document, 11. und 12.September 1997, Aachen.					
	ICOS; "3D Lead inspection Module (LHM)," Entire Document.					
M	www.trigonadcotech.com, "SMD 9000 Automated Inspection System for Surface Mount Devices," Entire Document, SMD 9000 product data sheet 2/25/97.					

EXAMINER SIGNATURE	21000472300	DATE CONSIDERED	Chara				
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